

RoHS Compliant Product  
A suffix of "-C" specifies halogen & lead-free

## DESCRIPTION

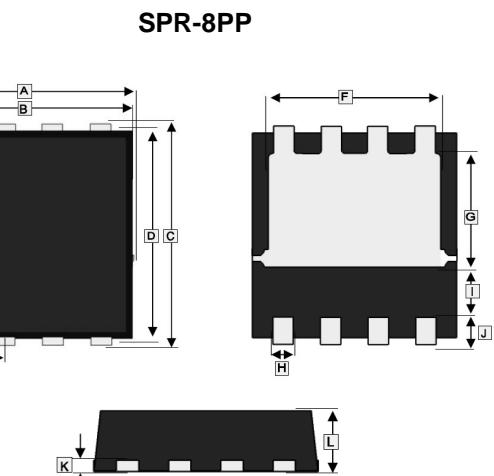
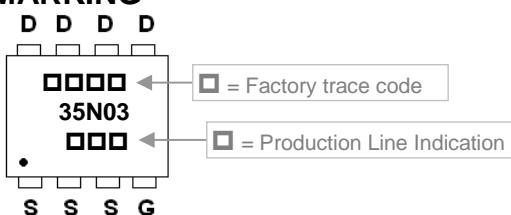
The SSPR62N03-C is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The SSPR62N03-C meet the RoHS and Green Product requirement with full function reliability approved.

## FEATURES

- Lower Gate Charge
- Simple Drive Requirement
- Fast Switching Characteristic

## MARKING



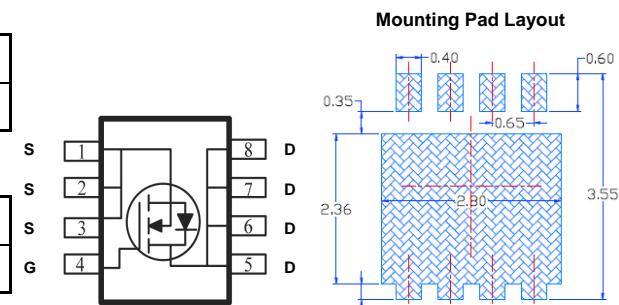
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	3.00	3.40	G	1.35	1.98
B	3.00	3.25	H	0.24	0.35
C	3.20	3.45	I	0.35 TYP.	
D	3.00	3.20	J	0.60 TYP.	
E	0.65 BSC.		K	0.10	0.25
F	2.39	2.60	L	0.70	0.90

## PACKAGE INFORMATION

Package	MPQ	Leader Size
SPR-8PP	3K	13 inch

## ORDER INFORMATION

Part Number	Type
SSPR62N03-C	Lead (Pb)-free and Halogen-free



\*Dimensions in millimeters

## ABSOLUTE MAXIMUM RATINGS ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>1</sup> @ $V_{GS}=10\text{V}$	$I_D$	62	A
		39	
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	150	A
Single Pulse Avalanche Energy <sup>3</sup>	$E_{AS}$	80	mJ
Avalanche Current	$I_{AS}$	40	A
Power Dissipation <sup>4</sup>	$P_D$	39	W
Operating Junction & Storage Temperature	$T_J, T_{STG}$	-55~150	°C
Thermal Resistance Rating			
Thermal Resistance Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	65	°C/W
Thermal Resistance Junction-Case <sup>1</sup>	$R_{\theta JC}$	3.2	

**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{DSS}$	30	-	-	V	$\text{V}_{GS}=0$ , $I_D=250\mu\text{A}$
Gate-Threshold Voltage	$\text{V}_{GS(\text{th})}$	1	-	3	V	$\text{V}_{DS}=\text{V}_{GS}$ , $I_D=250\mu\text{A}$
Forward Transfer conductance	$g_{fs}$	-	43	-	S	$\text{V}_{DS}=5\text{V}$ , $I_D=30\text{A}$
Gate-Source Leakage Current	$I_{GSS}$	-	-	$\pm 100$	nA	$\text{V}_{GS}= \pm 20\text{V}$
Drain-Source Leakage Current	$I_{DSS}$	-	-	1	$\mu\text{A}$	$\text{V}_{DS}=24\text{V}$ , $\text{V}_{GS}=0$
		-	-	5		$\text{V}_{DS}=24\text{V}$ , $\text{V}_{GS}=0$
Static Drain-Source On-Resistance <sup>2</sup>	$R_{DS(\text{ON})}$	-	4.3	5.8	$\text{m}\Omega$	$\text{V}_{GS}=10\text{V}$ , $I_D=12\text{A}$
		-	5.6	8		$\text{V}_{GS}=4.5\text{V}$ , $I_D=10\text{A}$
Gate Resistance	$R_g$	-	2	-	$\Omega$	$f=1\text{MHz}$
Total Gate Charge	$Q_g$	-	20	-	nC	$I_D=15\text{A}$ $\text{V}_{DS}=15\text{V}$ $\text{V}_{GS}=4.5\text{V}$
Gate-Source Charge	$Q_{gs}$	-	7.6	-		
Gate-Drain ("Miller") Change	$Q_{gd}$	-	7.2	-		
Turn-on Delay Time <sup>2</sup>	$T_{d(\text{on})}$	-	7.8	-		
Rise Time	$T_r$	-	15	-	nS	$\text{V}_{DD}=15\text{V}$ $I_D=15\text{A}$ $\text{V}_{GS}=10\text{V}$ $R_G=3.3\Omega$
Turn-off Delay Time	$T_{d(\text{off})}$	-	37.3	-		
Fall Time	$T_f$	-	10.6	-		
Input Capacitance	$C_{iss}$	-	2295	-		
Output Capacitance	$C_{oss}$	-	267	-	pF	$\text{V}_{GS}=0$ $\text{V}_{DS}=15\text{V}$ $f=1\text{MHz}$
Reverse Transfer Capacitance	$C_{rss}$	-	210	-		

**Guaranteed Avalanche Characteristics**

Single Pulse Avalanche Energy <sup>5</sup>	$E_{AS}$	31	-	-	mJ	$\text{V}_{DD}=15\text{V}$ , $L=0.1\text{mH}$ , $I_{AS}=25\text{A}$
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**Source-Drain Diode**

Diode Forward Voltage <sup>2</sup>	$V_{SD}$	-	-	1.2	V	$I_S=12\text{A}$ , $\text{V}_{GS}=0\text{V}$
Continuous Source Current <sup>16</sup>	$I_S$	-	-	62	A	$\text{V}_G=\text{V}_D=0$ , Force Current
Pulsed Source Current <sup>26</sup>	$I_{SM}$	-	-	150	A	
Reverse Recovery Time	$T_{rr}$	-	14	-	nS	$I_F=30\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$ ,
Reverse Recovery Charge	$Q_{rr}$	-	5	-	nC	$T_J=25^\circ\text{C}$

Notes:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2oz copper.
2. The data tested by pulsed, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
3. The  $E_{AS}$  data shows Max. rating, The test condition is  $\text{V}_{DD}=15\text{V}$ ,  $\text{V}_{GS}=10\text{V}$ ,  $L=0.1\text{mH}$ ,  $I_{AS}=40\text{A}$ .
4. The power dissipation is limited by  $150^\circ\text{C}$  junction temperature.
5. The Min. value is 100%  $E_{AS}$  tested guarantee.
6. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

## CHARACTERISTIC CURVES

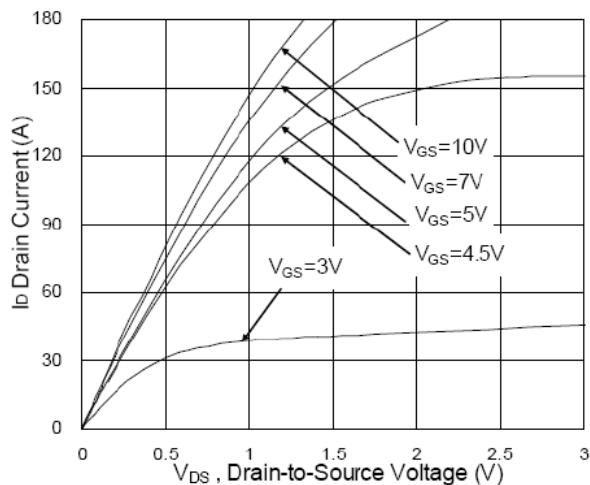


Fig.1 Typical Output Characteristics

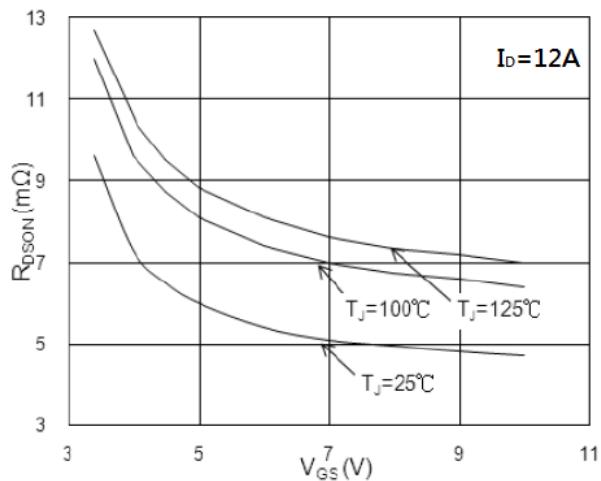


Fig.2 On-Resistance vs. G-S Voltage

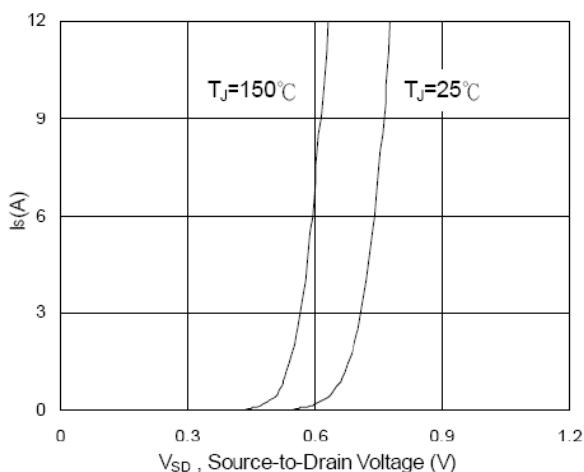


Fig.3 Forward Characteristics of Reverse

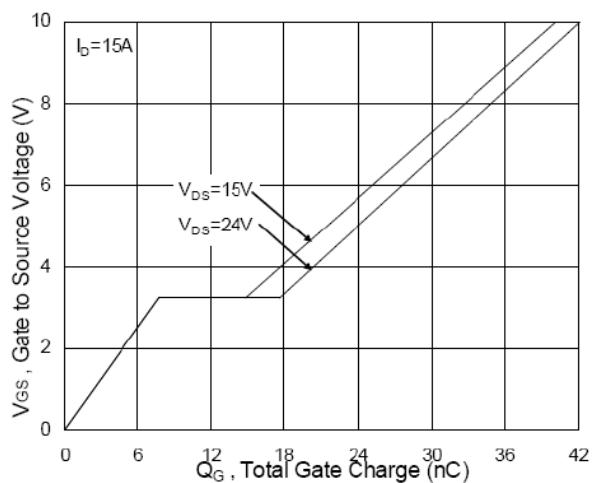


Fig.4 Gate-Charge Characteristics

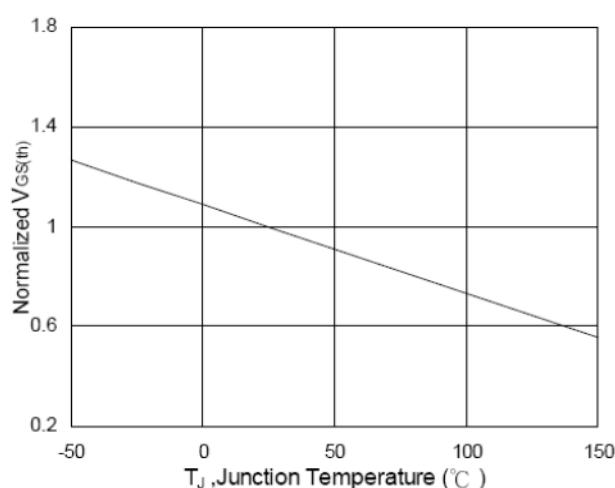


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$

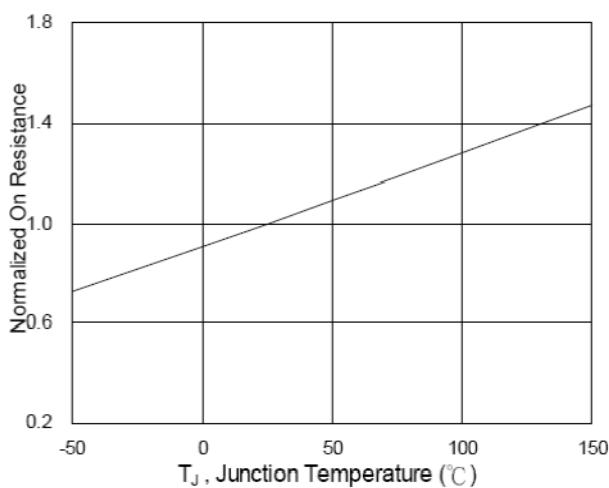


Fig.6 Normalized  $R_{DS(ON)}$  vs.  $T_J$

## CHARACTERISTIC CURVES

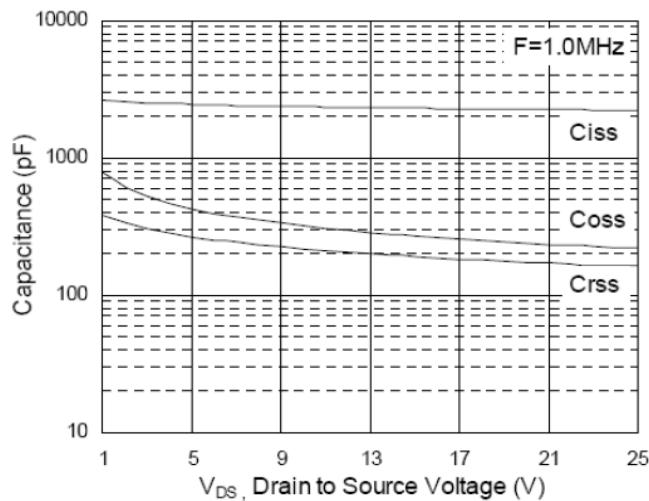


Fig.7 Capacitance

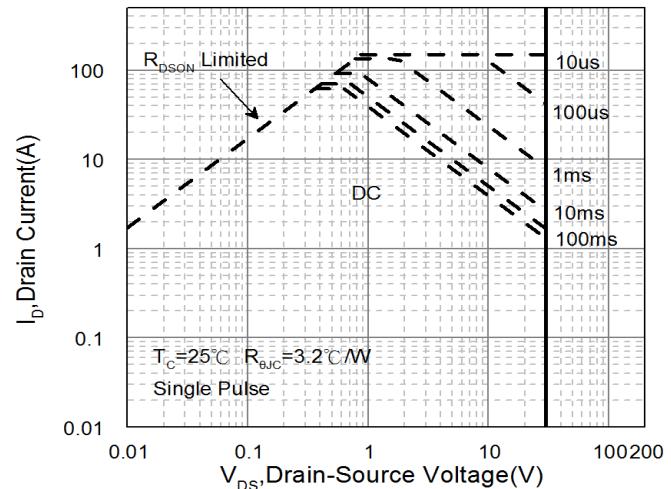


Fig.8 Safe Operating Area

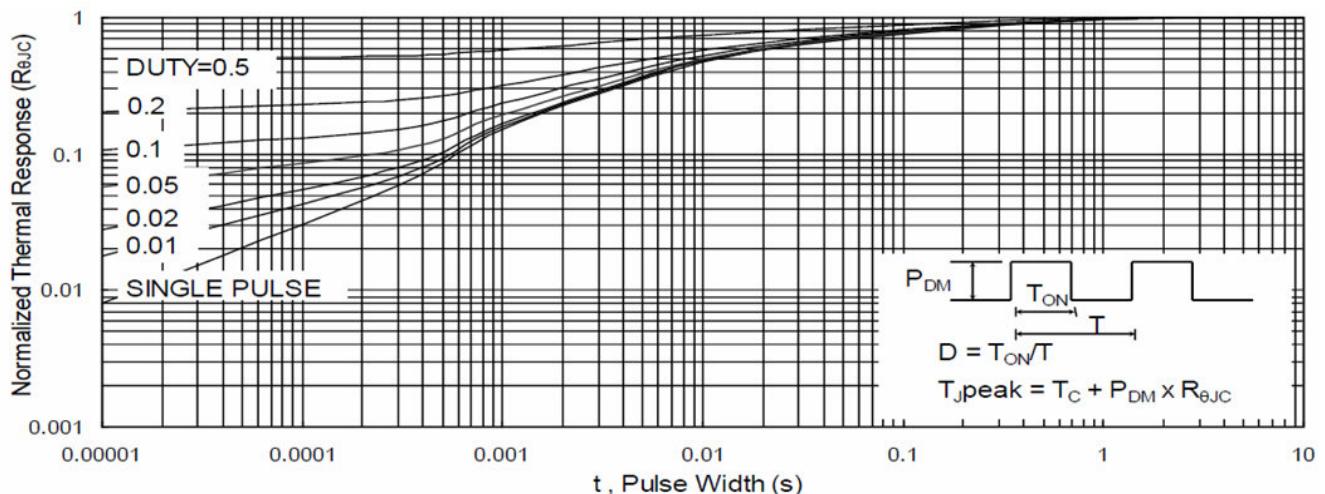


Fig.9 Normalized Maximum Transient Thermal Impedance

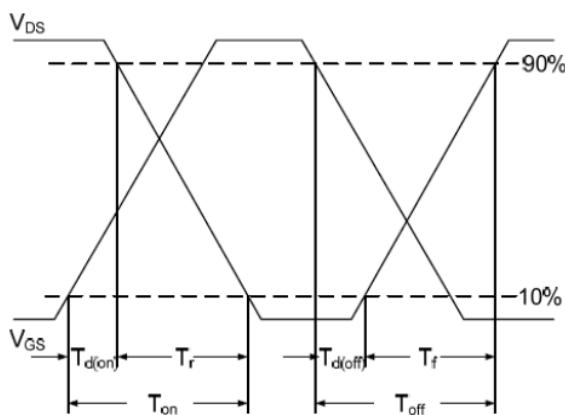


Fig.10 Switching Time Waveform

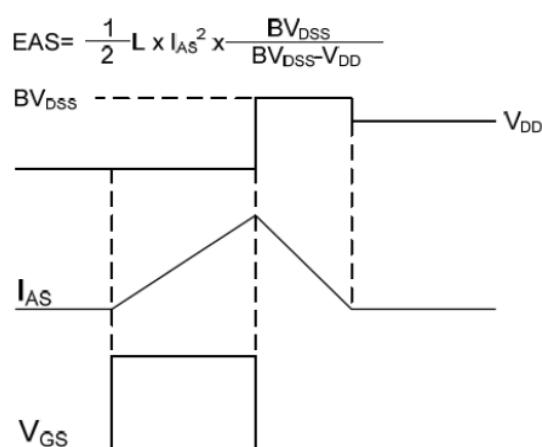


Fig.11 Unclamped Inductive Switching Waveform